Mirror-Module Driver-IC

The NCV7705/NCV7706 is a powerful Driver–IC for automotive body control systems. The IC is designed to control several loads in the front door of a vehicle. The monolithic IC is able to control mirror functions like mirror positioning, heating and folding. In addition, NCV7706 includes the electro–chromic mirror feature. The device features four high–side outputs to drive LEDs or incandescent bulbs (up to 5/10 W). To allow maximum flexibility, all lighting outputs can be PWM controlled thru PWM inputs (external signal source) or by an internal programmable PWM generator unit. The NCV7705/NCV7706 is controlled thru a 24 bit SPI interface with in–frame response.

Features

- Operating Range from 5.5 V to 28 V
- Four High–Side and Four Low–Side Drivers Connected as Half–Bridges
 - 2x Half-bridges $I_{load} = 0.75 \text{ A}$; $R_{DS(on)} = 1.6 \Omega$ @ 25°C
 - 2x Half-Bridges $I_{load} = 3 \text{ A}$; $R_{DS(on)} = 300 \text{ m}\Omega$ @ 25°C
- Four High-Side Lamp Drivers
 - 2x LED; $I_{load} = 0.3 \text{ A}$; $R_{DS(on)} = 1.4 \Omega @ 25^{\circ}\text{C}$
 - 1x 10 W; Configurable as LED Driver; $I_{load} = 2.5 \text{ A}$; $R_{DS(on)} = 300 \text{ m}\Omega$ @ 25°C
 - 1x 5 W; Configurable as LED Driver; I_{load} = 1.25 A; $R_{DS(on)}$ = 600 m Ω @ 25°C
- 1x High–Side Driver for Mirror Heating; $I_{load} = 6 \text{ A}$; $R_{DS(on)} = 100 \text{ m}\Omega$ @ 25°C
- Electro Chromic Mirror Control (NCV7706 Only)
 - 1x 6–Bit Selectable Output Voltage Controller
 - 1x LS for EC Control; $I_{load} = 0.75 \text{ A}$; $R_{DS(on)} = 1.6 \Omega @ 25^{\circ}\text{C}$
- Independent PWM Functionality for All Outputs
- Integrated Programmable PWM Generator Unit for All Lamp Driver Outputs
 - 7-bit / 10-bit Selectable Duty-cycle Setting Precision
- Programmable Soft-start Function to Drive Loads with Higher Inrush Currents as Current Limitation Value
- Multiplex Current Sense Analog Output for Advanced Load Monitoring
- Very Low Current Consumption in Standby Mode
- Charge Pump Output to Control an External Reverse Polarity Protection MOSFET
- 24-Bit SPI Interface for Output Control and Diagnostic
- Protection Against Short–circuit, Overvoltage and Over–temperature
- Downwards Pin-to-Pin and SPI Registers Compatible with NCV7707
- AEC-Q100 Qualified and PPAP Compliant



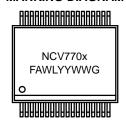
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SSOP36 EP DQ SUFFIX CASE 940AB

MARKING DIAGRAM



NCV770x = Specific Device Code

(x = 5, 5A or 6)

F = Fab Location (NCV7705A only)

A = Assembly Location

 WL
 = Wafer Lot

 YY
 = Year

 WW
 = Work Week

 G
 = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV7705DQR2G	SSOP36-EP	
NCV7705DQAR2G	GREEN	1500 / Tape & Reel
NCV7706DQR2G*	(Pb-Free)	11001

- †For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.
- * Contact local sales office for availability
- SSOP36-EP Power Package
- This is a Pb-Free Device

Typical Applications

- De-centralized Door Electronic Systems
- Body Control Units (BCUs)

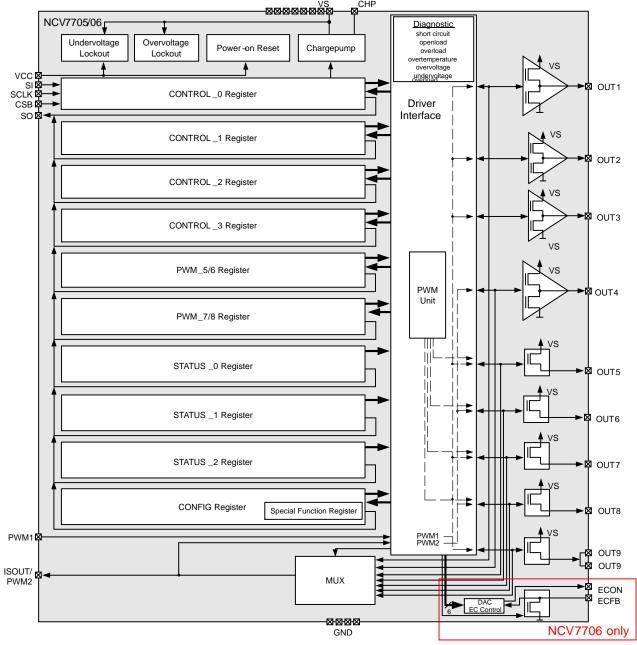


Figure 1. Block Diagram

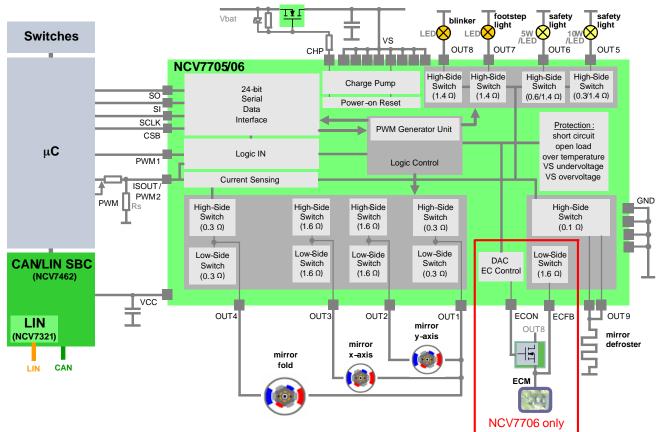


Figure 2. Application Diagram

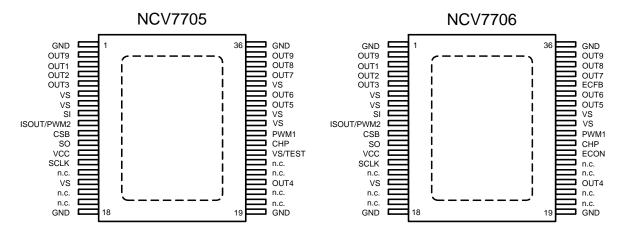


Figure 3. Pin Connections (Top View)

PIN FUNCTION DESCRIPTION

Pin No.	Pin Name	Pin Type	Description
1	GND	Ground	Ground Supply (all GND pins have to be connected externally)
2	OUT9	HS driver Output	Heater Output (has to be connected externally to pin 35)
3	OUT1	Half bridge driver Output	Mirror common Output
4	OUT2	Half bridge driver Output	Mirror x/y control Output
5	OUT3	Half bridge driver Output	Mirror x/y control Output
6	VS	Supply	Battery Supply Input (all VS pins have to be connected externally)
7	VS	Supply	Battery Supply Input (all VS pins have to be connected externally)
8	SI	Digital Input	SPI interface Serial Data Input
9	ISOUT/PWM2	Digital Input / Analog Output	PWM control Input / Current Sense Output. This pin is a bidirectional pin. Depending on the selected multiplexer bits, an image of the instant current of the corresponding HS stage can be read out. This pin can also be used as PWM control input pin for OUT6 and OUT8.
10	CSB	Digital Input	SPI interface Chip Select
11	SO	Digital Output	SPI interface Serial Data Output
12	VCC	Supply	Logic Supply Input
13	SCLK	Digital Input	SPI interface Shift Clock
14	n.c.		Not connected
15	VS	Supply	Battery Supply Input (all VS pins have to be connected externally)
16	n.c.	,,,,	Not connected
17	n.c.		Not connected
18	GND	Ground	Ground Supply (all GND pins have to be connected externally)
19	GND	Ground	Ground Supply (all GND pins have to be connected externally)
20	n.c.		Not connected
21	n.c.		Not connected
22	OUT4	Half bridge driver Output	Mirror Fold Output
23	n.c.	3	Not connected
24	n.c.		Not connected
25	VS/TEST (NCV7705 only)	Supply	Test Input, has to be connected to VS in application
	ECON (NCV7706 only)	ECM driver Output	Electrochromic mirror control DAC output. If the Electrochrome feature is selected, this output controls an external Mosfet, otherwise it remains in high–impedance state.
			If the electrochrome feature is not used in the application and not selected via SPI the pin can be connected to VS.
26	CHP	Analog Output	Reverse Polarity FET Control Output
27	PWM1	Digital Input	PWM control Input for OUT1-4, OUT5/7, OUT9
28	VS	Supply	Battery Supply Input (all VS pins have to be connected externally)
29	VS	Supply	Battery Supply Input (all VS pins have to be connected externally)
30	OUT5	HS driver Output	LED / Bulb Output
31	OUT6	HS driver Output	LED / Bulb Output
32	VS (NCV7705 only)	Supply	Connect to VS pins externally (no power connection)
	ECFB (NCV7706 only)	ECM Input / Output	Electrochromic Mirror Feedback Input, Fast discharge transistor Output
33	OUT7	HS driver Output	LED Output
34	OUT8	HS driver Output	LED Output
35	OUT9	HS driver Output	Heater Output (has to be connected externally to pin 2)
36	GND	Ground	Ground Supply (all GND pins have to be connected externally)
	Heat slug	Ground	Substrate; Heat slug has to be connected to all GND pins

ABSOLUTE MAXIMUM RATINGS

Symbol	Rating	Min	Max	Unit
Vs	Power supply voltage - Continuous supply voltage - Transient supply voltage (t < 500 ms, "clamped load dump")	-0.3 -0.3	28 40	V
V _{CC}	Logic supply	-0.3	5.5	V
Vdig	DC voltage at all logic pins (SO, SI, SCLK, CSB, PWM1)	-0.3	V _{CC} + 0.3	V
Visout/pwm2	Current monitor output / PWM2 logic input	-0.3	V _{CC} + 0.3	V
Vchp	Charge pump output (the most stringent value is applied)	–25 Vs – 25	40 Vs + 15	V
Voutx, Vecon, Vecfb	Static output voltage (OUT1-9, ECON, ECFB)	-0.3	Vs + 0.3	V
lout1/4	OUT1/4 Output current - T _J > 25°C - T _J < 25°C	-5 -5.5	5 5.5	А
lout2/3	OUT2/3 Output current - T _J > 25°C - T _J < 25°C	-1.25 -1.35	1.35 1.35	А
lout5	OUT5 Output current - DC - Transient	-5	5	А
lout6	OUT6 Output current - DC - Transient	-2.5	2.5	А
lout7/8	OUT7/8 Output current - DC - Transient	-1.25	1.25	А
lout9	OUT9 Output current - DC - Transient	-10	10	А
lout_ecfb (NCV7706 only)	ECFB Output current		1.25	Α
ESD_HBM	ESD Voltage, Human Body Model (HBM); (100 pF, 1500 Ω) (Note 1) – All pins – Output pins OUT1–4 and ECFB to GND (all unzapped pins grounded)	-2 -4	2 4	kV
ESD_CDM	ESD according to CDM (Charge Device Model) (Note 1) – All pins – Corner pins	-500 -750	500 750	V
TJ	Operating junction temperature range	-40	150	°C
Tstg	Storage temperature range	-55	150	°C
MSL	Moisture sensitivity level (Note 2)	MS	SL3	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. This device series incorporates ESD protection and is tested by the following methods:

ESD Human Body Model tested per AEC-Q100-002 (EIA/JESD22-A114)

ESD Charge Device Model tested per EIA/JES D22/C101, Field Induced Charge Model

2. For soldering information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D

THERMAL CHARACTERISTICS

Symbol	Rating	Value	Unit
$R_{\theta JA}$	Thermal Characteristics, SSOP36–EP, 1–layer PCB Thermal Resistance, Junction–to–Air (Note 3)	49.4	°C/W
$R_{\theta JA}$	Thermal Characteristics, SSOP36–EP, 4–layer PCB Thermal Resistance, Junction–to–Air (Note 4)	24	°C/W

^{3.} Values based on PCB of 76.2 x 114.3 mm, 72 µm copper thickness, 20% copper area coverage and FR4 PCB substrate.

^{4.} Values based on PCB of 76.2 x 114.3 mm, 72 / 36 µm copper thickness (signal layers / internal planes), 20 / 90% copper area coverage (signal layers / internal planes) and FR4 PCB substrate.

ELECTRICAL CHARACTERISTICS

4.5 V < V_{CC} < 5.25 V, 8 V < Vs < 18 V, -40° C < T_J < 150°C; unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
PPLY			•			
Vs	Supply voltage	Functional (see V _{UV_VS} / V _{OV_VS}) Parameter specification	5.5 8		28 18	V
Is(standby)	Supply Current (VS), Standby mode	Standby mode, $ \text{VS} = 16 \text{ V}, 0 \text{ V} \leq \text{V}_{CC} \leq 5.25 \text{ V}, \\ \text{CSB} = \text{V}_{CC}, \text{OUTx/ECx} = \text{floating}, \\ \text{SI} = \text{SCLK} = 0 \text{ V}, \text{T}_{\text{J}} < 85^{\circ}\text{C} \\ (\text{T}_{\text{J}} = 150^{\circ}\text{C}) $		3.5 (9)	12 (25)	μΑ
Is(active)	Supply current (VS), Active mode	Active mode, VS = 16 V, OUTx/ECx = floating		8	20	mA
I _{CC} (standby)	Supply Current (VCC), Standby mode	Standby mode, $V_{CC} = 5.25 \text{ V}$, $SI = SCLK = 0 \text{ V}$, $T_J < 85^{\circ}C$ $(T_J = 150^{\circ}C)$		4.5 (15)	6 (50)	μΑ
I _{CC} (active)	Supply current (VCC), Active mode	Active mode, VS = 16 V, OUTx/ECx = floating		6.5	8	mA
I(standby)	Total Standby mode supply current (Is + I _{CC})	Standby mode, VS = 16 V, T _J < 85°C, CSB = V _{CC} , OUTx/ECx = floating		8	18	μΑ
ERVOLTAGE A	ND UNDERVOLTAGE DETECTION					
Vuv_vs(on)		VS increasing	5.6		6.2	V
Vuv_vs(off)	VS Undervoltage detection	VS decreasing	5.2		5.8	V
Vuv_vs(hys)	VS Undervoltage hysteresis	Vuv_vs(on) - Vuv_vs(off)		0.65		V
Vov_vs(off)	V0.0	VS increasing	20		24.5	V
Vov_vs(on)	VS Overvoltage detection	VS decreasing	19		23.5	V
Vov_vs(hys)	VS Overvoltage hysteresis	Vov_vs(off) – Vov_vs(on)		2		V
Vuv_vcc(off)	VOC I la demonte me detection	V _{CC} increasing			2.9	V
Vuv_vcc(on)	VCC Undervoltage detection	V _{CC} decreasing	2			V
Vuv_vcc(hys)	VCC Undervoltage hysteresis	$V_{uv_VCC(off)} - V_{uv_VCC(on)}$		0.11		V
td_uv	VS Undervoltage filter time	Time to set the power supply fail bit UOV_OC in the Global Status Byte	6		13	μS
td_ov	VS Overvoltage filter time	Time to set the power supply fail bit UOV_OC in the Global Status Byte	50		100	μS
ARGE PUMP O	UTPUT CHP					
Vchp8	Chargepump Output Voltage	$Vs = 8 V$, $Ichp = -60 \mu A$	Vs + 6	Vs + 9.5	Vs + 13	V
Vchp10	Chargepump Output Voltage	Vs = 10 V, Ichp = -80 μA	Vs + 8	Vs + 11	Vs + 13	V
Vchp12	Chargepump Output Voltage	VS > 12 V, Ichp = -100 μA	Vs + 9.5	Vs + 11	Vs + 13	V
Ichp	Chargepump Output current	VS = 13.5 V, Vchp = Vs + 10 V	-750		-95	μΑ

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
MIRROR COMMON	OUTPUT (X/Y, FOLD) OUT1, OUT4			•	•	
		$T_J = 25^{\circ}C$, lout1,4 = ±1.5 A		0.3		
Ron_out1,4	On–resistance HS or LS	$T_J = 125^{\circ}C$, lout1,4 = ±1.5 A			0.6	Ω
loc1,4_hs	Overcurrent threshold HS	$T_J < 25^{\circ}C$ $T_J \ge 25^{\circ}C$	-5.5 -5		-3	А
loc1,4_ls	Overcurrent threshold LS	$T_J < 25^{\circ}C$ $T_J \ge 25^{\circ}C$	3		5.5 5	А
Vlim1,4	Vds voltage limitation HS or LS		2		3	V
luld1,4_hs	Underload detection threshold HS		-80		- 5	mA
luld1,4_ls	Underload detection threshold LS		5		80	mA
td_HS1,4(on)	Output delay time, HS Driver on	Time from CSB going high to		2.5	12	μs
td_HS1,4(off)	Output delay time, HS Driver off	V(OUT1,4) = 0.1·Vs / 0.9·Vs (on/off)		3	12	μS
td_LS1,4(on)	Output delay time, LS Driver on	Time from CSB going low to		1	12	μS
td_LS1,4(off)	Output delay time, LS Driver off	$V(OUT1,4) = 0.9 \cdot Vs / 0.1 \cdot Vs (on/off)$		1.5	12	μS
tdLH1,4	Cross conduction protection time, low–to–high transition including LS slew–rate			0.5	22	μs
tdHL1,4	Cross conduction protection time, high-to-low transition including HS slew-rate			5.5	22	μs
lleak_act_hs1,4	Output HS leakage current, Active mode	V(OUT1,4) = 0 V	-40	-16		μΑ
lleak_act_ls1,4	Output pull-down current, Active mode	V(OUT1,4) = VS		105	185	μΑ
Ileak_stdby_hs1,4	Output HS leakage current, Standby mode	V(OUT1,4) = 0 V	- 5			μΑ
lleak_stdby_ls1,4	Output pull-down current, Standby mode	$V(OUT1,4) = VS, T_J \ge 25^{\circ}C$ $V(OUT1,4) = VS, T_J < 25^{\circ}C$		80	120 175	μΑ
td_uld1,4	Underload blanking delay		430		610	μS
tdb_old1,4	Overload shutdown blanking delay	Timer started after output activation	16		25	μS
td_old1,4	Overload shutdown filter time	Timer started after blanking delay elapsed	5		25	μs
frec1,4L	Recovery frequency, slow recovery mode	CONTROL_3.OCRF = 0	1		4	kHz
frec1,4H	Recovery frequency, fast recovery mode	CONTROL_3.OCRF = 1	2		6	kHz
dVout1,4	Slew rate of HS driver	Vs = 13.5 V, Rload = 16 Ω to GND	1.3	2.3	3.3	V/μs

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
MIRROR X/Y POSIT	TIONING OUTPUTS OUT2, OUT3			•		
_		$T_J = 25^{\circ}C$, lout2,3 = ±0.5 A		1.6		Ω
Ron_out2,3	On–resistance HS or LS	$T_J = 125^{\circ}C$, lout2,3 = ±0.5 A			3	Ω
loc2,3_hs	Overcurrent threshold HS	$T_J < 25^{\circ}C$ $T_J \ge 25^{\circ}C$	-1.35 -1.25		-0.75	А
loc2,3_ls	Overcurrent threshold LS	$T_J < 25^{\circ}C$ $T_J \ge 25^{\circ}C$	0.75		1.35 1.25	А
Vlim2,3	Vds voltage limitation HS or LS		2		3	V
luld2,3_hs	Underload detection threshold HS		-32	-20	-10	mA
luld2,3_ls	Underload detection threshold LS		10	20	32	mA
td_HS2,3(on)	Output delay time, HS Driver on	Time from CSB going high to		2.5	6	μS
td_HS2,3(off)	Output delay time, HS Driver off	V(OUT2,3) = 0.1·Vs / 0.9·Vs (on/off)		3	6	μs
td_LS2,3(on)	Output delay time, LS Driver on	Time from CSB going low to		1	6	μS
td_LS2,3(off)	Output delay time, LS Driver off	V(OUT2,3) = 0.9·Vs / 0.1·Vs (on/off)		1	6	μs
tdLH2,3	Cross conduction protection time, low–to–high transition including LS slew–rate			0.5	22	μs
tdHL2,3	Cross conduction protection time, high-to-low transition including HS slew-rate			5.5	22	μs
lleak_act_hs2,3	Output HS leakage current, Active mode	V(OUT2,3) = 0 V	-40	-16		μΑ
lleak_act_ls2,3	Output pull-down current, Active mode	V(OUT2,3) = VS		105	185	μΑ
Ileak_stdby_hs2,3	Output HS leakage current, Standby mode	V(OUT2,3) = 0 V	- 5			μΑ
Ileak_stdby_ls2,3	Output pull-down current, Standby mode	$V(OUT2,3) = VS, T_J \ge 25^{\circ}C$ $V(OUT2,3) = VS, T_J < 25^{\circ}C$		80	120 175	μ Α μ Α
td_uld2,3	Underload blanking delay		430		610	μs
tdb_old2,3	Overload shutdown blanking delay	Timer started after output activation	16		25	μs
td_old2,3	Overload shutdown filter time	Timer started after blanking delay elapsed	16		50	μS
frec2,3L	Recovery frequency, slow recovery mode	CONTROL_3.OCRF = 0	1		4	kHz
frec2,3H	Recovery frequency, fast recovery mode	CONTROL_3.OCRF = 1	2		6	kHz
dVout2,3	Slew rate of HS driver	Vs = 13.5 V, Rload = 64 Ω to GND	1.3	2.3	3.3	V/μs

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
BULB / LED DRIVE	R OUTPUT OUT5					·
D (5.10D	On-resistance to supply,	$T_J = 25^{\circ}C$, lout5 = -1 A		0.3		
Ron_out5_ICB	HS switch, Bulb mode	$T_J = 125^{\circ}C$, lout5 = -1 A			0.6	Ω
D 15.15D	On-resistance to supply,	$T_J = 25^{\circ}C$, lout5 = -0.2 A		1.4		
Ron_out5_LED	HS switch, LED mode	$T_J = 125^{\circ}C$, lout5 = -0.2 A			3	Ω
Ilim5_ICB	Output current limitation to GND, Bulb mode	$T_J < 25^{\circ}C$ $T_J \ge 25^{\circ}C$	-3.9 -3.7		-2.5	А
llim5_LED	Overcurrent threshold, LED mode		-1.1		-0.5	А
luld5_ICB	Underload detection threshold, Bulb mode		-65		-5	mA
luld5_LED	Underload detection threshold, LED mode		-15		-5	mA
td_OUT5_ICB(on)	Output delay time, Driver on, Bulb mode	Time from CSB going high to		15	48	
td_OUT5_ICB(off)	Output delay time, Driver off, Bulb mode	$V(OUT5) = 0.1 \cdot Vs / 0.9 \cdot Vs \text{ (on/off)};$ Rload = 16 Ω		21	48	μS
td_OUT5_LED(on)	Output delay time, Driver on, LED mode	Time from CSB going high to		15	48	
td_OUT5_LED(off)	Output delay time, Driver off, LED mode	$V(OUT5) = 0.1 \cdot Vs / 0.9 \cdot Vs \text{ (on/off)};$ Rload = 64 Ω		21	48	μS
lleak_act5	Output leakage current, Active mode	V(OUT5) = 0 V	-15			μΑ
lleak_stdby5	Output leakage current, Standby mode	V(OUT5) = 0 V	-5			μΑ
Ileak_out_vs5	Output leakage current	V(OUT5) = VS			1	mA
td_uld5_ICB	Underload blanking delay Bulb mode		1350		1910	μs
td_uld5_LED	Underload blanking delay LED mode		430		610	μS
tdb_old_ICB5	Overload shutdown blanking delay, Bulb mode	Timer started after output activation	200		290	μs
td_old_ICB5	Overload shutdown filter time, Bulb mode	Timer started after blanking delay elapsed	100		160	μs
tdb_old_LED5	Overload shutdown blanking delay, LED mode	Timer started after output activation	200		290	μs
td_old_LED5	Overload shutdown filter time, LED mode	Timer started after blanking delay elapsed	50		100	μS
frec5L	Recovery frequency, slow recovery mode recovery	CONTROL_3.OCRF = 0	1		2.1	kHz
frec5H	Recovery frequency, fast recovery mode (LED mode only)	CONTROL_3.OCRF = 1	2		6	kHz
dVout5_ICB	Slew rate, Bulb mode	Vs = 13.5 V, Rload = 16 Ω		0.22		V/µs
dVout5_LED	Slew rate, LED mode	Vs = 13.5 V, Rload = 64 Ω		0.22		V/µs
dVout5_ocr	Slew rate in overcurrent recovery mode	Vs = 13.5 V, Rload = 16 Ω	1	2	3	V/μs

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
BULB / LED DRIVE	R OUTPUT OUT6					
D (0.10D	On-resistance to supply,	$T_J = 25^{\circ}C$, lout6 = -0.5 A		0.6		
Ron_out6_ICB	HS switch, Bulb mode	$T_J = 125^{\circ}C$, lout6 = -0.5 A			1.2	Ω
D-1-1010 LED	On-resistance to supply,	$T_J = 25^{\circ}C$, lout6 = -0.2 A		1.4		
Ron_out6_LED	HS switch, LED mode	$T_J = 125^{\circ}C$, lout6 = -0.2 A			3	Ω
Ilim6_ICB	Output current limitation to GND, Bulb mode	$T_J < 25^{\circ}C$ $T_J \ge 25^{\circ}C$	-1.95 -1.85		-1.25	Α
Ilim6_LED	Overcurrent threshold, LED mode		-1.1		-0.5	Α
luld6_ICB	Underload detection threshold, Bulb mode		-30		-2.5	mA
luld6_LED	Underload detection threshold, LED mode		-15		-5	mA
td_OUT6_ICB(on)	Output delay time, Driver on, Bulb mode	Time from CSB going high to		15	48	
td_OUT6_ICB(off)	Output delay time, Driver off, Bulb mode	$V(OUT6) = 0.1 \cdot Vs / 0.9 \cdot Vs \text{ (on/off)};$ Rload = 16 Ω		21	48	μS
td_OUT6_LED(on)	Output delay time, Driver on, LED mode	Time from CSB going high to		15	48	
td_OUT6_LED(off)	Output delay time, Driver off, LED mode	$V(OUT6) = 0.1 \cdot Vs / 0.9 \cdot Vs \text{ (on/off)};$ Rload = 64 Ω		21	48	μS
lleak_act6	Output leakage current, Active mode	V(OUT6) = 0 V	-15			μΑ
lleak_stdy6	Output leakage current, Standby mode	V(OUT6) = 0 V	-5			μΑ
Ileak_out_vs6	Output leakage current	V(OUT6) = VS			1	mA
td_uld6_ICB	Underload blanking delay Bulb mode		1350		1910	μs
td_uld6_LED	Underload blanking delay LED mode		430		610	μs
tdb_old_ICB6	Overload shutdown blanking delay, Bulb mode	Timer started after output activation	200		290	μs
td_old_ICB6	Overload shutdown filter time, Bulb mode	Timer started after blanking delay elapsed	100		160	μS
tdb_old_LED6	Overload shutdown blanking delay, LED mode	Timer started after output activation	200		290	μS
td_old_LED6	Overload shutdown filter time, LED mode	Timer started after blanking delay elapsed	50		100	μS
frec6L	Recovery frequency, slow recovery mode recovery	CONTROL_3.OCRF = 0	1		2.1	kHz
frec6H	Recovery frequency, fast recovery mode (LED mode only)	CONTROL_3.OCRF = 1	2		6	kHz
dVout6_ICB	Slew rate, Bulb mode	Vs = 13.5 V, Rload = 16 Ω		0.22		V/μs
dVout6_LED	Slew rate, LED mode	Vs = 13.5 V, Rload = 64 Ω		0.22		V/μs
dVout6_ocr	Slew rate in overcurrent recovery mode	Vs = 13.5 V, Rload = 16 Ω	1	2	3	V/μs

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
LED DRIVER OUTF	PUTS OUT7, OUT8					
Don out7.0	On-resistance to supply,	$T_J = 25^{\circ}C$, lout7,8 = -0.2 A		1.4		Ω
Ron_out7,8	HS switch	T _J = 125°C, lout7,8 = -0.2 A			3	Ω
loc7,8	Overcurrent threshold		-0.6		-0.3	Α
luld7,8	Underload detection threshold		-18		-4	mA
td_OUT7,8(on)	Output delay time, Driver on	Time from CSB going high to			48	
td_OUT7,8(off)	Output delay time, Driver off	V(OUT7,8) = 0.1 Vs / 0.9 Vs (on/off)			48	μS
lleak_act7,8	Output leakage current, Active mode	V(OUT7,8) = 0 V	-10	18		μΑ
Ileak_stdby7,8	Output leakage current, Standby mode	V(OUT7,8) = 0 V	-5	23		μΑ
Ileak_out_vs7,8	Output leakage current	V(OUT7,8) = VS			1	mA
td_uld7,8	Underload blanking delay		430		610	μs
tdb_old_OUT7,8	Overload shutdown blanking delay	Timer started after output activation	200		290	μs
td_old_OUT7,8	Overload shutdown filter time	Timer started after blanking delay elapsed	16		50	μs
frec7,8L	Recovery frequency, slow recovery mode	CONTROL_3.OCRF = 0	1		4	kHz
frec7,8H	Recovery frequency, fast recovery mode	CONTROL_3.OCRF = 1	2		6	kHz
dVout7,8	Slew rate	Vs = 13.5 V, Rload = 64 Ω		0.2		V/μs
HEATER OUTPUT	OUT9	•				-
D 10	On–resistance to supply,	$T_J = 25^{\circ}C$, lout9 = -3 A		0.1		Ω
Ron_out9	HS switch	$T_J = 125^{\circ}C$, lout9 = -3 A			0.2	Ω
loc9	Overcurrent threshold		-10		-6	Α
Iuld9	Underload detection threshold		-300		-30	mA
td_OUT9(on)	Output delay time, Driver on	Time from CSB going high to		3	12	
td_OUT9(off)	Output delay time, Driver off	$V(OUT9) = 0.1 \cdot Vs / 0.9 \cdot Vs$ (on/off); Rload = 64 Ω		3	12	μS
lleak_act9	Output leakage current, Active mode	V(OUT9) = 0 V	-10			μА
Ileak_stdby9	Output leakage current, Standby mode	V(OUT9) = 0 V	-5			μА
lleak_out9_vs	Output leakage current	V(OUT9) = VS			1	mA
td_uld9	Underload blanking delay		430		610	μS
tdb_old_OUT9	Overload shutdown blanking delay	Timer started after output activation	30		48	μS
td_old_OUT9	Overload shutdown blanking delay	Timer started after blanking delay elapsed	16		25	μs
frec9L	Recovery frequency, slow recovery mode	CONTROL_3.OCRF = 0	1		4	kHz
frec9H	Recovery frequency, fast recovery mode	CONTROL_3.OCRF = 1	2		6	kHz
dVout9	Slew rate	$Vs = 13.5 V$, $Rload = 4 \Omega$	1.3	2.3	3.3	V/μs

ELECTRICAL CHARACTERISTICS (continued)

4.5 V < V_{CC} < 5.25 V, 8 V < Vs < 18 V, -40° C < T_J < 150°C; unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ELECTROCHROMI	C MIRROR CONTROL (ECFB, ECO	N) (NCV7706 ONLY)				
		T _J = 25°C, lecfb = 0.5 A		1.6		Ω
Ron_ecfb	On–resistance to GND, LS switch	T _J = 125°C, lecfb = 0.5 A			3	Ω
llim_ecfb_src	Output current limitation to GND	Vs = 13.5 V, V _{CC} = 5 V	0.75		1.25	Α
Vlim_ecfb	Vds voltage limitation	Output enabled	2		3	V
luld_ecfb	Underload detection threshold	Vs = 13.5 V, V _{CC} = 5 V	10	20	35	mA
td_ecfb(on)	Output delay time, LS Driver on	Vs = 13.5 V, V _{CC} = 5 V,		1	12	
td_ecfb(off)	Output delay time, LS Driver off	Rload = 64 Ω , V(ECFB) = 0.9·VS / 0.1·VS (on /off)		2	12	μS
Ileak_ecfb_stdby		Vecfb = Vs, Standby mode	-15		15	μΑ
lleak_ecfb_act	Output leakage current, LS off	Vecfb = Vs, Active mode	-10		10	μΑ
td_uld_ecfb	Underload blanking delay		430		610	μS
tdb_old_ecfb	Overload shutdown blanking delay	Timer started after output activation	30		48	μS
td_old_ecfb	Overload shutdown filter time	Timer started after blanking delay elapsed	16		50	μS
dVecfb/dt(on/off)	Slew rate of ECFB, LS switch	$Vs = 13.5 \text{ V}, V_{CC} = 5 \text{ V}, \text{Rload} = 64 \Omega$		5		V/μs
	M : 50	CONTROL_2.FSR = 1	1.4		1.6	V
Vctrl_max	Maximum EC control voltage	CONTROL_2.FSR = 0	1.12		1.28	V
DNL	Differential non linearity	1 LSB = 23.8 mV	-1		1	LSB
dV_ecfb	Voltage deviation between target and ECFB	dV_ecfb = Vtarget – Vecfb, lecon < 1 μA gain offset	–5% –1 LSB		+5% +1 LSB	mV
dV_ecfb_lo	Difference voltage between target and ECFB sets flag if Vecfb is below target	dV_ecfb = Vtarget - Vecfb, Toggle bit STATUS_2.ECLO = 1		120		mV
dV_ecfb_hi	Difference voltage between target and ECFB sets flag if Vecfb is above target	dV_ecfb = Vtarget - Vecfb, Toggle bit STATUS_2.ECHI = 1		-120		mV
Vecon_min_hi	FOON and and the second	lecon = −10 μA	4.5		5.5	.,
Vecon_max_lo	ECON output voltage range	lecon = 10 μA	0		0.7	V
		Vtarget > Vecfb + 500 mV, Vecfb = 3.5 V	-100		-10	μΑ
lecon	ECON output current capability	Vtarget < Vecfb - 500 mV, Vecon = 0.5 V, Vtarget = 1 LSB, Vecfb = 0.5 V	10		100	μА
Recon_pd	Pull-down resistance at ECON in fast discharge mode	Vecon = 0.7 V, CONTROL_1.ECEN = 1, CONTROL_1.LSECFB = 1, CONTROL_1.DAC[5:0] = 0			5	kΩ
lq_econ	ECON quiescent current	Vecon = Vs, CONTROL_1.ECEN = 0			1	μΑ
t_disc	Auto-discharge pulse width	Config.LSPWM=1	230	300	360	ms
t_rec	Auto-discharge blanking time	Config.LSPWM=1	2.25	3	3.75	ms
Vthdisc_abs	PWM discharge threshold level V(ECON) (Note 5)	Config.LSPWM=1	350	400	450	mV
Vthdisc_diff	PWM discharge threshold level V(ECON) – V(ECFB) (Note 5)	Config.LSPWM=1	-50	0	50	mV

^{5.} If V(ECON) < Vthdisc_abs or V(ECON)-V(ECFB) < Vthdisc_diff then ECON_LOW =1; see description in paragraph Controller for Electro-chromic Glass

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit			
CURRENT SENSE MONITOR OUTPUT ISOUT/PWM2									
Vis	Current Sense output functional voltage range	V _{CC} = 5 V, Vs = 8–20 V	0		V _{CC} – 0.5	V			
	Current Sense output ratio OUT1/4			12000					
	Current Sense output ratio OUT9 and 5 (low on–resistance bulb mode)	K = lout / lis.		10000					
Kis	Current Sense output ratio OUT6 (low on–resistance bulb mode)	V = 100t / 11s, $V = 100t / 11s$, $V = 100t /$		5000					
	Current Sense output ratio OUT7/8 and 5/6 (high on–resistance LED mode)	78		2000					
	Current Sense output accuracy OUT1/4	$0.3 \text{ V} \le \text{Vis} \le 4.5 \text{ V}, \text{ V}_{CC} = 5 \text{ V}$ lout1/4 = 0.5–2.9 A	-12.5% - 1% FS		12.5% + 1% FS				
	Current Sense output accuracy OUT5/6 (low on–resistance bulb mode)	$0.3 \text{ V} \leq \text{Vis} \leq 4.5 \text{ V}, \text{ V}_{CC} = 5 \text{ V}$ 10ut5 = 0.5-1.3 A, 10ut6 = 0.25-0.65 A	-14% - 1% FS		14% + 1% FS				
lis,acc (Notes 6 and 7)	Current Sense output accuracy OUT5/6 (high on-resistance LED mode)	$0.3 \text{ V} \le \text{Vis} \le 4.5 \text{ V}, \text{V}_{CC} = 5 \text{ V}$ lout5,6 = 0.1–0.3 A	-14% - 1% FS		14% + 1% FS				
	Current Sense output accuracy OUT7/8	$0.3 \text{ V} \leq \text{Vis} \leq 4.5 \text{ V}, \text{ V}_{CC} = 5 \text{ V}$	-8% - 1.5% FS		8% + 1.5% FS				
	Current Sense output accuracy OUT9	$0.3 \text{ V} \le \text{Vis} \le 4.5 \text{ V}, \text{ V}_{CC} = 5 \text{ V}$ lout9 = 0.5–5.9 A	-10% - 1.5% FS		10% + 1.5% FS				
tis_blank	Current Sense blanking time	Blanking time after current sense selection or driver activation	50		65	μs			
tis	Current Sense settling time	0 V to FSR (full scale range)		230	265	μS			

^{6.} Current sense output accuracy = Isout_Isout_ideal relative to Isout_ideal 7. FS (Full scale) = Ioutmax/Kis

Symbol	Parameter	Min	Тур	Max	Unit	
IGITAL INPUTS (CSB, SCLK, PWM1/2, SI		•			
Vinl	Input low level	V _{CC} = 5 V			0.3·V _{CC}	V
Vinh	Input high level	V _{CC} = 5 V	0.7·V _{CC}			V
Vin_hyst	Input hysteresis		500			mV
Rcsb_pu	CSB pull-up resistor	V _{CC} = 5 V, 0 V < Vcsb < 0.7·V _{CC}	30	120	250	kΩ
Rsclk_pd	SCLK pull-down resistor	V _{CC} = 5 V, Vsclk = 1.5 V	30	60	220	kΩ
Rsi_pd	SI pull-down resistor	V _{CC} = 5 V, Vsi = 1.5 V	30	60	220	kΩ
Rpwm1_pd	PWM1 pull-down resistor	V _{CC} = 5 V, Vpwm1 = 1.5 V	30	60	220	kΩ
Rpwm2_pd	PWM2 pull–down resistor	V _{CC} = 5 V, Vpwm2 = 1.5 V, current sense disabled	30	60	220	kΩ
lleak_isout	Output leakage current	current sense enabled	-2		2	μΑ
Ccsb / sclk / pwm1/2 Pin capacitance		0 V < V _{CC} < 5.25 V (Note 8)			10	pF
GITAL INPUTS (CSB, SCLK, SI; TIMING					
tsclk	Clock period	V _{CC} = 5 V		1000		ns
tsclk_h	Clock high time		115			ns
tsclk_l	Clock low time		115			ns
tset_csb	CSB setup time, CSB low before rising edge of SCLK		400			ns
tset_sclk	SCLK setup time, SCLK low before rising edge of CSB		400			ns
tset_si	SI setup time		200			ns
thold_si	SI hold time		200			ns
tr_in	Rise time of input signal SI, SCLK, CSB				100	ns
tf_in Fall time of input signal SI, SCLK, CSB					100	ns
tcsb_hi_stdby Minimum CSB high time, switching from Standby mode		Transfer of SPI–command to input register, valid before tsact mode transition delay expires		5	10	μs
tcsb_hi_min	Minimum CSB high time, Active mode			2	4	μs

^{8.} Values based on design and/or characterization.

ELECTRICAL CHARACTERISTICS (continued)

4.5 V < V_{CC} < 5.25 V, 8 V < Vs < 18 V, -40° C < T_J < 150°C; unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
IGITAL OUTPUT	r so					
Vsol	Output low level	Iso = 5 mA			0.2·V _{CC}	V
Vsoh	Output high level	Iso = -5 mA	0.8·V _{CC}			V
lleak_so	Tristate leakage current		-10		10	μΑ
Cso	Tristate input capacitance	Vcsb = V _{CC} , 0 V < V _{CC} < 5.25 V (Note 8)			10	pF
GITAL OUTPUT	T SO; TIMING		•			
tr_so	SO rise time	Cso = 100 pF		80	140	ns
tf_so	SO fall time	Cso = 100 pF		50	100	ns
ten_so_tril	SO enable time from tristate to low level	Cso = 100 pF, Iload = 1 mA, pull-up load to V _{CC}		100	250	ns
tdis_so_ltri	SO disable time from low level to tristate	Cso = 100 pF, Iload = 4 mA, pull-up load to V _{CC}		380	450	ns
ten_so_trih	SO enable time from tristate to high level	Cso = 100 pF, lload = -1 mA, pull-down load to GND		100	250	ns
tdis_so_htri SO disable time from high level to tristate		Cso = 100 pF, Iload = -4 mA, pull-down load to GND		380	450	ns
td_so	SO delay time	$Vso < 0.3 \cdot V_{CC}$, or $Vso > 0.7 \cdot V_{CC}$, $Cso = 100 \text{ pF}$		50	250	ns

8. Values based on design and/or characterization.

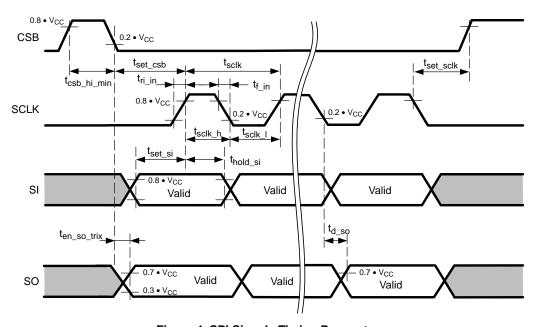


Figure 4. SPI Signals Timing Parameters

ELECTRICAL CHARACTERISTICS (continued) 4.5 V < V_{CC} < 5.25 V, 8 V < Vs < 18 V, -40°C < T_{J} < 150°C; unless otherwise noted.

Symbol	Parameter	Min	Тур	Max	Unit	
THERMAL PROTE	CTION					
Tjtw_on	Temperature warning threshold	Junction temperature	140		160	°C
Tjtw_hys	Thermal warning hysteresis			5		°C
Tjsd_on	Thermal shutdown threshold, T _J increasing	Junction temperature	160		180	°C
Tjsd_off	Thermal shutdown threshold, T _J decreasing	Junction temperature	160			°C
Tjsd_hys	Thermal shutdown hysteresis			5		°C
Tjsdtw_delta	Temperature difference between warning and shutdown threshold			20		°C
td_tx	Filter time for thermal warning and shutdown	TW / TSD Global Status bits	10		100	μs
OPERATING MOD	ES TIMING					
tact	Time delay for mode change from Unpowered mode into Standby mode	SPI communication ready after V _{CC} reached V _{uv_VCC(off)} threshold			30	μS
tsact	Time delay for mode change from Standby mode into Active mode	Time until output drivers are enabled after CSB going to high and CONTROL_0.MODE = 1		210	400	μS
tacts	Time delay for mode change from Active mode into Standby mode via SPI	Time until output drivers are disabled after CSB going to high and CONTROL_0.MODE = 0			300	μs
INTERNAL PWM C	CONTROL UNIT (OUT5 – OUT8)					
PWMIo	PWM frequency, low selection	CONTROL_2.PWMI = 1, PWMx.FSELx = 0	135	170	200	Hz
PWMhi	PWM frequency, high selection	175	225	260	Hz	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

DETAILED OPERATING AND PIN DESCRIPTION

General

The NCV7705/NCV7706 provides four half-bridge drivers, five independent high-side outputs and a programmable PWM control unit for free configuration. Strict adherence to integrated circuit die temperature is necessary, with a static maximum die temperature of 150°C. This may limit the number of drivers enabled at one time. Output drive control and fault reporting are handled via the SPI (Serial Peripheral Interface) port. A SPI-controlled mode control provides a low quiescent sleep current mode when the device is not being utilized. A pull down is provided on the SI and SCLK inputs to ensure they default to a low state in the event of a severed input signal. A pull-up is provided on the CSB input disabling SPI communication in the event of an open CSB input.

Supply Concept

Power Supply Scheme - VS and VCC

The Vs power supply voltage is used to supply the half bridges and the high-side drivers. An all-internal chargepump is implemented to provide the gate-drive voltage for the n-channel type high-side transistors. The VCC voltage is used to supply the logic section of the IC, including the SPI interface.

Due to the independent logic supply voltage the control and status information will not be lost in case of a loss of Vs supply voltage. The device is designed to operate inside the specified parametric limits if the VCC supply voltage is within the specified voltage range (4.5 V to 5.25 V). Between the operational level and the VCC undervoltage threshold level (Vuv_VCC) it is guaranteed that the device remains in a safe functional state without any inadvertent change to logic information.

Device / Module Ground Concept

The high-side output stages OUT5-9 are designed to handle DC output voltage conditions down to -0.3 V and allow for short negative transient currents due to parasitic line inductances. Therefore the application has to take care that these ratings are not violated under abnormal operating conditions (module loss of GND, ground shift if load connected to external GND) by either implementing external bypass diodes connected to GND or a direct connection between load-GND and module-GND. Since these output stages are designed to drive resistive loads, restrictions on maximum inductance / clamping energy apply.

The heat slug is not hard—connected to internal GND rail. It has to be connected externally.

Power Up/Down Control

In order to prevent uncontrolled operation of the device during power/up down, an undervoltage lockout feature is implemented. Both supply voltages (V_{CC} and Vs) are

monitored for undervoltage conditions supporting a safe power—up transition. When Vs drops below the undervoltage threshold Vuv_vs(off) (Vs undervoltage threshold) all output stages are switched to high—impedance state and the global status bit UOV_OC is set. This bit is a multi information bit in the Global Status Byte which is set in case of overcurrent, Vs over— and undervoltage. In case of undervoltage the status bit STATUS_2.VSUV is set, too.

Bit CONTROL_3.OVUVR (Vs under-/overvoltage recovery behavior) can be used to select the desired recovery behavior after a Vs under-voltage event. In case of OVUVR = 0, all output stages return to their programmed state as soon as Vs recovers back to its normal operating range. If OVUVR is set, the automatic recovery function is disabled thus the output stages will remain in high-impedance condition until the status bits have been cleared by the microcontroller. To avoid high current oscillations in case of output short to GND and low Vs voltage conditions, it is recommended to disable the Vs-auto-recovery by setting OVUVR = 1.

Chargepump

In Standby mode, the chargepump is disabled. After enabling the device by setting bit CONTROL_0.MODE to active (1), the internal oscillator is started and the voltage at the CHP output pin begins to increase. The output drivers are enabled after a delay of tsact once MODE was set to active.

Driver Outputs

Output PWM Control

For all half-bridge outputs as well as the HS output OUT9 the device features the possibility to logically combine the SPI-setting with a PWM signal that can be provided to the inputs PWM1 and ISOUT/PWM2, respectively. Each of the outputs has a fixed PWM signal assigned which is shown in Table 1. The PWM modulation is enabled by the respective bits in the control registers (CONTROL_2.OUTx_PWMx and CONTROL_3.OUTx_PWMx). In case of using pin ISOUT/PWM2, the application design has to take care of either disabling the current sense feature or to provide sufficient overdrive capability to maintain proper logic input levels for the PWM input.

In addition to the external signal control, all lighting outputs (OUT5–9) can also be PWM controlled via an internal PWM generator unit. While the PWM frequency can be individually selected between 170 Hz and 225 Hz thru bits PWMx.FSELx, the duty cycle can be programmed with 7 or 10–bits resolution PWMx.PW[6/9:0]. The selection between the different signal sources for these outputs is performed by programming bit CONTROL_2.PWMI. Default value is 0 (external signal source). The general principle of the PWM generation control scheme is shown in Figure 5.

Table 1. PWM CONTROL SCHEME

		PWM Control Input	
		CONTROL_	2.PWMI = 1
Output	CONTROL_2.PWMI = 0	CONFIG.PWM_RESEN=0	CONFIG.PWM_RESEN=1
OUT1	PWM1	PWM1	PWM1
OUT2	PWM1	PWM1	PWM1
OUT3	PWM1	PWM1	PWM1
OUT4	PWM1	PWM1	PWM1
OUT5	PWM1	PWM_5/6.PW5[6:0]	PWM_5.PW5[9:0]
OUT6	ISOUT/PWM2	PWM_5/6.PW6[6:0]	PWM_6.PW6[9:0]
OUT7	PWM1	PWM_7/8.PW7[6:0]	PWM_7.PW7[9:0]
OUT8	ISOUT/PWM2	PWM_7/8.PW8[6:0]	PWM_8.PW8[9:0]
OUT9	PWM1	PWM1	PWM1

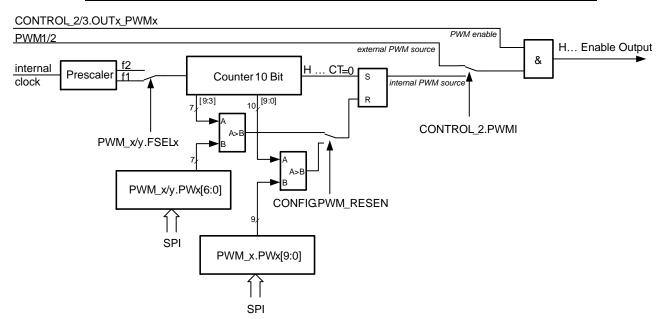


Figure 5. PWM Generation Diagram

Programmable Soft-start Function to Drive Loads with Inrush Current Behavior

Loads with startup currents higher than the overcurrent limits (e.g. inrush current of bulbs, block current of motors and cold resistance of heaters) can be driven using the programmable soft-start function (Overcurrent auto-recovery mode). Each output driver provides a corresponding overcurrent recovery bit (CONTROL 2/3.OCRx) to control the output behavior in case of a detected overcurrent event. If auto-recovery is enabled, the device automatically re-enables the output after a programmable recovery time. For all half-bridge outputs as well as the high-side outputs OUT5-9 and OUT5/6 in LED mode, the recovery frequency can be selected via SPI. OUT5/6 in bulb mode provides a fixed recovery frequency. The PWM modulated current will provide sufficient average current to power up the load (e.g. heat up the bulb) until the load reaches a steady state condition. The device itself cannot distinguish between a

real overload and a non linear load like a bulb. Therefore a real overload condition can only be qualified by time. It is recommended to only enable auto—recovery for a minimum amount of time to drive the connected load into a steady state condition. After turning off the auto—recovery function, the respective channel is automatically disabled if the overload condition still persists.

Inductive Loads

Each half bridge (OUT1-4) is built by internally connected low-side and high-side N-MOS transistors. Due to the built-in body diodes of the output transistors, inductive loads can be driven at the outputs without external free-wheeling diodes. The high-side drivers OUT5 to OUT9 are designed to drive resistive loads. Therefore only a limited clamping energy (W < 1 mJ) can be dissipated by the device. For inductive loads (L > 100 μ H) an external

freewheeling diode connected between GND and the corresponding output is required.

The low-side driver at ECFB does not feature any freewheeling diode or clamping structure to handle inductive loads.

Current Sensing

Current Sense Output / PWM2 Input (Bidirectional Pin ISOUT/PWM2)

The current sense output allows a more precise analysis of the actual state of the load rather than the basic detection of an under— or overload condition. The sense output provides an image of the actual load current at the selected high side driver transistor. The current monitor function is available for high current half—bridge outputs (OUT1 and OUT4), the high current high—side output (OUT9) as well as for the all bulb and LED outputs (OUT5–8).

The current sense ratio is fixed for the low resistance outputs OUT1/4/9 and OUT5/6 (bulb mode) to 1/12000 resp. 1/10000 and for the high ohmic outputs OUT7/8 and OUT5/6 (LED mode) to 1/2000. To prevent from false readouts, the signal at pin ISOUT is blanked after switching on the driver until correct settlement of the circuitry (> 65 μs). Bits CONTROL_3.IS[3:0] are used to select the output to be multiplexed to the current sense output.

The NCV7705/NCV7706 provides a sample–and–hold functionality for the current sense output to enable precise and simple load current diagnostics even during PWM operation of the respective output. While in active high–side output state, the current provided at ISOUT reflects a (low–pass–filtered) image of the actual output current, the IS–output current is sampled and held constant as soon as the HS output transistor is commanded off via PWM (low–side or high–impedant on half–bridge outputs, high–impedant on HS–outputs). In case no previous current information is available in the Sample–and–hold stage (current sense channel changed while actual channel is commanded off) the sample stage is reset so that it reflects zero output current.

Electro Chromic Mirror (NCV7706 ONLY)

Controller for Electro-chromic Glass

The voltage of the electro-chromic element connected at pin ECFB can be controlled to a target value which is set by Control Register 1 (bits CONTROL_1.DAC[5:0]). Setting bit CONTROL_1.ECEN enables this function. At the same time OUT8 is enabled, regardless of its own control bit CONTROL_1.HS8 and the respective PWM setting. An on-chip differential amplifier is used to control an external logic-level N-MOS pass device that delivers the power to

the electro–chromic element. The target voltage at ECFB is binary coded with a selectable full scale range (bit CONTROL_2.FSR). The default clamping value for the output voltage (CONTROL_2.FSR = 0) is 1.2 V, by setting CONFIG_1.FSR to "1", the maximum output voltage is 1.5 V. The resolution of the DAC output voltage is independent of the full–scale–range selection.

The charging of the mirror (positive slope) is determined by the positive slew rate of the transconductance amplifier and the compensation capacitor, while in case of capacitive loads, the negative slope is mainly determined by the current consumption thru the load and its capacitance. To allow fast settling time changing from higher to lower output voltage values, the device provides two modes of operation:

- 1. Fast discharge: When the target output voltage is set to 0 V and bit CONTROL_1.LS_ECFB is set, the voltage at pin ECFB is pulled to ground by a $1.6~\Omega$ low-side switch.
- PWM discharge: In case of PWM discharge being activated (CONFIG.ECM_LSPWM = 1 and CONTROL_1.LS_ECFB = 1) (Figure 6):
 - a. The circuit regulation starts in normal regulation. The DAC value is turned to new lower value.
 - b. If the loop is detected out of regulation for a time longer than t_rec (~3 ms), the ECON voltage is detected low (internal signal ECON_LOW = 1), the regulator is switched off (DAC voltage at 0) and the fast discharge transistor is activated for ~300 ms (t_disc). During this fast discharge, the ECON output is pulled low to prevent from shoot—thru currents.
 - c. At the end of the discharge pulse t_disc the fast discharge is switched off and the regulation loop is activated again (with DAC to the correct wanted value), so the loop goes back to step b.) and the ECON_LOW comparator is observed again. Before starting a discharge pulse, the ECLO and ECHI comparator data is latched.

The feedback loop out of regulation is monitored by comparing V(ECON) versus V(ECFB) and versus 400 mV. If the regulation is activated and ECON is below ECFB, or below 400 mV, then the loop is detected as out of regulation and internal signal ECON_LOW is made 1. By activating the PWM discharge feature, the overcurrent recovery function is automatically disabled, regardless of the setting in CONTROL_2.OC_ECFB.

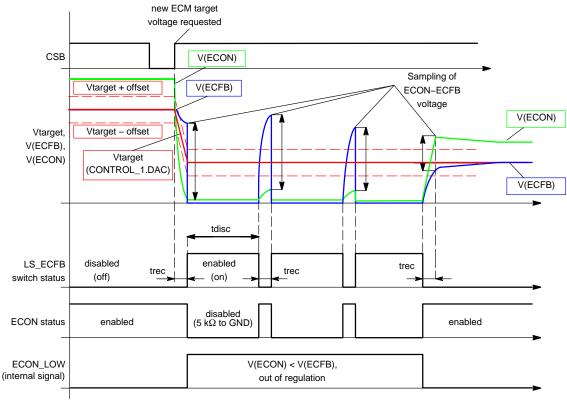


Figure 6. PWM Discharge Mode for ECFB

The controller provides a chip—internal diode from ECFB (Anode) to pin ECON (Cathode) to protect the external MOSFET. A capacitor of at least 4.7 nF has to be added to pin ECON for stability of the control loop. It is recommended to place 220 nF capacitor between ECFB and ground to increase the stability.

The status of the voltage control loop is reported via SPI. Bit STATUS_2.ECHI = 1 indicates that the voltage on ECFB is higher than the programmed target value, STATUS_2.ECLO = 1 indicates that the ECFB voltage is below the programmed value. Both status bits are valid if they are stable for at least 150 μ s (settling time of the

regulation loop). If PWM discharge is enabled (CONFIG.ECM_LSPWM = 1), STATUS_2.ECHI is latched at the end of the discharge cycle, therefore if set it indicates that the device is in active discharge operation.

Since OUT8 is the output of a high–side driver, it contains the same diagnostic functions as the other high–side drivers (e.g. switch–off during overcurrent condition). In electro–chrome mode, OUT8 can't be controlled by PWM. For noise immunity reasons, it is recommended to place the loop capacitors at ECON as well as another capacitor between ECFB and GND as close as possible to the respective pins.

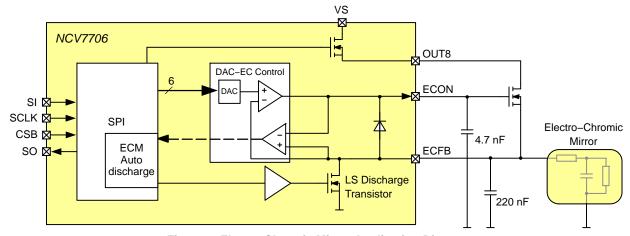


Figure 7. Electro Chromic Mirror Application Diagram

Diagnostic Functions

All diagnostic functions (overcurrent, underload, power supply monitoring, thermal warning and thermal shutdown) are internally filtered. The failure condition has to be valid for the minimum specified filtering time (td_old, td_uld, td_uvov and td_tx) before the corresponding status bit in the status register is set. The filter function is used to improve the noise immunity of the device. The undercurrent and temperature warning functions are intended for information purpose and do not affect the state of the output drivers. An overcurrent condition disables the corresponding output driver while a thermal shutdown event disables all outputs into high impedance state. Depending on the setting of the overcurrent recovery bits in the input register, the driver can either perform an auto-retry or remain latched off until the microcontroller clears the corresponding status bits. Overtemperature shutdown is latch-off only, without auto-retry functionality.

Overvoltage / Undervoltage Shutdown

If the supply voltage Vs rises above the switch off voltage Vov_vs(off) or falls below Vuv_vs(off), all output transistors are switched to high-impedance state and the global status bit UOV_OC (multi information) is set. The status flag STATUS_2.VSOV, resp. STATUS_2.VSUV is set, too, to log the over-/under-voltage event. The bit CONTROL_3.OVUVR can be used to determine the recovery behavior once the Vs supply voltage gets back into the specified nominal operating range. OVUVR = 0 enables auto-recovery, with OVUVR = 1 the output stages remain in high impedance condition until the status flags have been cleared. Once set, STATUS2.VSOV / VSUV can only be reset by a read&clear access to the status register STATUS 2.

Thermal Warning and Overtemperature Shutdown

The device provides a dual—stage overtemperature protection. If the junction temperature rises above Tjtw_on, a temperature warning flag (TW) is set in the Global Status Byte and can be read via SPI. The control software can then react onto this overload condition by a controlled disable of individual outputs. If however the junction temperature reaches the second threshold Tjsd_on, the thermal shutdown bit TSD is set in the Global Status Byte and all output stages are switched into high impedance state to protect the device. The minimum shutdown delay for overtemperature is td_tx. The output channels can be re—enabled after the device cooled down and the TSD flag has been reset by the microcontroller by setting CONTROL_0.MODE = 0.

OpenIoad (UnderIoad) Detection

The openload detection monitors the load current in the output stage while the transistor is active. If the load current is below the openload detection threshold for at least td_uld, the corresponding bit (ULDx) is set in the status registers STATUS_1/2. The status of the output remains unchanged. Once set, ULDx remains set regardless of the actual load condition. It has to be reset by a read&write access to the corresponding status register.

Overload Detection

An overcurrent condition is indicated by the flag (UOV_OC) in the Global Status Byte after a filter time of at least td_old. The channel dependent overcurrent flags are set in the status registers (STATUS_0/2.OCx) and the corresponding driver is switched into high impedance state to protect the device. Each low-side and high-side driver stage provides its own overcurrent flag. Resetting this overcurrent flag automatically re-enables the respective output (provided it is still enabled thru the Control register). If the over current recovery function is enabled, the internal chip logic automatically resets the overcurrent flag after a fixed delay time, generating a PWM modulated current with a programmable duty cycle. Otherwise the status bits have to be cleared by the microcontroller by a read&clear access to the corresponding status register.

Cross-current Protection

All six half-bridges are protected against cross-currents by internal circuitry. If one driver is turned off (LS or HS), the activation of the other driver of the same output will be automatically delayed by the cross current protection mechanism until the active driver is safely turned off.

Mode Control

Wake-up and Mode Control

Two different modes are available:

- Active mode
- Standby mode

After power-up of VCC the device starts in Standby mode. Pulling the chip-select signal CSB to low level causes the device to change into Active mode (analog part active).

After at least 10 µs delay, the first SPI communication is valid and bit CONTROL_0.MODE can be used to set the desired mode of operation. If bit MODE remains reset (0) or CSB remains low longer than tcsb_low_stdby, the device returns to the Standby mode after an internal delay of max. 8 µs, clearing all register content and setting all output stages into high impedance state.

VCC Power-up Delay (tact) Output stages Hi-Z Delay (tsact) MODE = 1 SPI not rea MODE = 1CSB = 0CSB = 0CSB = 1 and MODE = 0 Standby Active Output stages High-Z MODF = 0Delay time and expired CSB = 1 Delay (tacts) Output stages contro

Figure 8. Mode Transitions Diagram

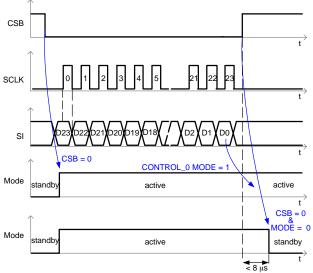


Figure 9. Mode Timing Diagram

SPI Control

General Description

The 4-wire SPI interface establishes a full duplex synchronous serial communication link between the NCV7705/NCV7706 and the application's microcontroller. The NCV7705/NCV7706 always operates in slave mode whereas the controller provides the master function. A SPI access is performed by applying an active-low slave select signal at CSB. SI is the data input, SO the data output. The SPI master provides the clock to the NCV7705/NCV7706 via the SCLK input. The digital input data is sampled at the rising edge at SCLK. The data output SO is in high impedance state (tri-state) when CSB is high. To readout the global error flag without sending a complete SPI frame, SO indicates the corresponding value as soon as CSB is set to active. With the first rising edge at SCLK after the high-to-low transition of CSB, the content of the selected register is transferred into the output shift register.

The NCV7705/NCV7706 provides four control registers (CONTROL_0/1/2/3), two PWM configuration registers (PWM_7/8 and PWM_9/10), three status registers (STATUS_0/1/2) and one general configuration register (CONFIG). Each of these register contains 16-bit data, together with the 8-bit frame header (access type, register address), the SPI frame length is therefore 24 bits. In addition to the read/write accessible registers, the NCV7705/NCV7706 provides five 8-bit ID registers (ID_HEADER, ID_VERSION, ID_CODE1/2 and ID_SPI-FRAME) with 8-bit data length. The content of these registers can still be read out by a 24-bit access, the data is then transferred in the MSB section of the data frame.

SPI Frame Format

Figure 10 shows the general format of the NCV7705/NCV7706 SPI frame.

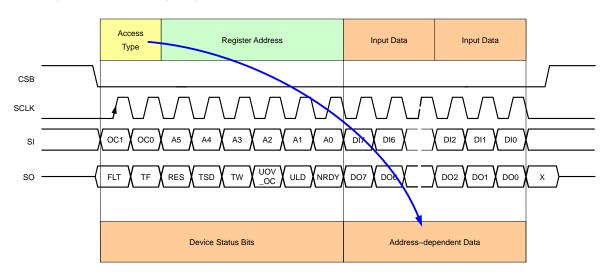


Figure 10. SPI Frame Format

24-bit SPI Interface

Both 24-bit input and output data are MSB first. Each SPI-input frame consists of a command byte followed by two data bytes. The data returned on SO within the same frame always starts with the global status byte. It provides general status information about the device. It is then followed by 2 data bytes (in-frame response) which content depends on the information transmitted in the command byte. For write access cycles, the global status byte is followed by the previous content of the addressed register.

Chip Select Bar (CSB)

CSB is the SPI input pin which controls the data transfer of the device. When CSB is high, no data transfer is possible and the output pin SO is set to high impedance. If CSB goes low, the serial data transfer is allowed and can be started. The communication ends when CSB goes high again.

Serial Clock (SCLK)

If CSB is set to low, the communication starts with the rising edge of the SCLK input pin. At each rising edge of SCLK, the data at the input pin Serial IN (SI) is latched. The data is shifted out thru the data output pin SO after the falling edges of SCLK. The clock SCLK must be active only within the frame time, means when CSB is low. The correct transmission is monitored by counting the number of clock pulses during the communication frame. If the number of SCLK pulses does not correspond to the frame width indicated in the SPI-frame-ID (Chip ID Register, address 3Eh) the frame will be ignored and the communication failure bit "TF" in the global status byte will be set. Due to this safety functionality, daisy chaining the SPI is not possible. Instead, a parallel operation of the SPI bus by controlling the CSB signal of the connected ICs is recommended.

Serial Data In (SI)

During the rising edges of SCLK (CSB is low), the data is transferred into the device thru the input pin SI in a serial

way. The device features a stuck—at—one detection, thus upon detection of a command = FFFFFFh, the device will be forced into the Standby mode. All output drivers are switched off.

Serial Data Out (SO)

The SO data output driver is activated by a logical low level at the CSB input and will go from high impedance to a low or high level depending on the global status bit, FLT (Global Error Flag). The first rising edge of the SCLK input after a high to low transition of the CSB pin will transfer the content of the selected register into the data out shift register. Each subsequent falling edge of the SCLK will shift the next bit thru SO out of the device.

Command Byte / Global Status Byte

Each communication frame starts with a command byte (Table 2). It consists of an operation code (OP[1:0], Table 3) which specifies the type of operation (Read, Write, Read & Clear, Readout Device Information) and a six bit address (A[5:0], Table 4). If less than six address bits are required, the remaining bits are unused but are reserved. Both Write and Read mode allow access to the internal registers of the device. A "Read & Clear"—access is used to read a status register and subsequently clear its content. The "Read Device Information" allows to read out device related information such as ID—Header, Product Code, Silicon Version and Category and the SPI—frame ID. While receiving the command byte, the global status byte is transmitted to the microcontroller. It contains global fault information for the device, as shown in Table 6.

ID Register

Chip ID Information is stored in five special 8-bit ID registers (Table 5). The content can be read out at the beginning of the communication.

Table 2	COMMAND	RYTF /	GLOBAL	STATUS I	BYTE STRUCTURE	
I able 2.	COMMINATE		OLODAL			

		Command Byte (IN) / Global Status Byte (OUT)								
Bit	23	22	21	20	19	18	17	16		
NCV7705/06 IN	OP1	OP0	A5	A4	А3	A2	A1	A0		
NCV7705/06 OUT	FLT	TF	RESB	TSD	TW	UOV_OC	ULD	NRDY		
Reset Value	1	0	0	0	0	0	0	1		

Table 3. COMMAND BYTE, ACCESS MODE

OP1	OP0	Description
0	0	Write Access (W)
0	1	Read Access (R)
1	0	Read and Clear Access (RC)
1	1	Read Device ID (RDID)

Table 4. COMMAND BYTE, REGISTER ADDRESS

A[5:0]	Access	Description	Content
00h	R/W	Control Register CONTROL_0	Device mode control, Bridge outputs control
01h	R/W	Control Register CONTROL_1	High-side outputs control, ECM control (NCV7706 only)
02h	R/W	Control Register CONTROL_2	Bridge outputs recovery control, PWM enable, ECM setup (NCV7706 only)
03h	R/W	Control Register CONTROL_3	High-side outputs recovery control, PWM enable, Current Sense selection
08h	R/W	PWM Control Register PWM_5/6	PWM control register for OUT5/6 (7b control only)
09h	R/W	PWM Control Register PWM_7/8	PWM control register for OUT7/8 (7b control only)
10h	R/RC	Status Register STATUS_0	Bridge outputs Overcurrent diagnosis
11h	R/RC	Status Register STATUS_1	Bridge outputs Underload diagnosis
12h	R/RC	Status Register STATUS_2	HS outputs Overcurrent and Underload diagnosis, Vs Over– and Undervoltage, EC–mirror
13h	R/W	PWM Control Register PWM_5	PWM control register for OUT5 (10b control only)
14h	R/W	PWM Control Register PWM_6	PWM control register for OUT6 (10b control only)
15h	R/W	PWM Control Register PWM_7	PWM control register for OUT7 (10b control only)
16h	R/W	PWM Control Register PWM_8	PWM control register for OUT8 (10b control only)
3Fh	R/W	Configuration Register CONFIG	Mask bits for global fault bits

Table 5. CHIP ID INFORMATION

A[5:0]	Access	Description	Content			
00h	RDID	ID header	4300h			
01h	RDID	Version	0001h (NCV7705, NCV7706) 0004h (NCV7705A)			
02h	RDID	Product Code 1	7700h			
03h	RDID	Product Code 2	0500h (NCV7705) 0600h (NCV7706)			
3Eh	RDID	SPI-Frame ID	0200h			

Table 6. GLOBAL STATUS BYTE CONTENT

FLT		Global Fault Bit						
0	No fault Condition	Failures of the Global Status Byte, bits [6:0] are always linked to the Global Fault Bit FLT. This bit is generated by an OR combination of all failure bits of the device (RESB inverted). It is reflected via the SO pin while CSB is held low and NO clock signal is present (before first positive edge of						
1	Fault Condition	SCLK). The flag will remain valid as long as CSB is held low. This operation does not cause the Transmission error Flag in the Global Status Byte to be set. Signals TW and ULD can be masked.						
	1							
TF		SPI Transmission Error						
0	No Error	If the number of clock pulses within the previous frame was unequal 0 (FLT polling) or 24. The						
1	Error	frame was ignored and this flag was set.						
	ı							
RESB		Reset Bar (Active low)						
0	Reset	Bit is set to "0" after a Power-on-Reset or a stuck-at-1 fault at SI (SPI-input data = FFFFFFh)						
1	Normal Operation	has been detected. All outputs are disabled.						
TSD		Overtemperature Shutdown						
0	No Thermal Shutdown	Thermal Shutdown Status indication. In case of a Thermal Shutdown, all output drivers including the charge pump output are deactivated (high impedance). The TSD bit has to be cleared thru a SW roost to reactivate the output drivers and the observe men output.						
1	Thermal Shutdown	SW reset to reactivate the output drivers and the chargepump output.						
	1							
TW		Thermal Warning						
0	No Thermal Warning	This bit indicates a pre–warning level of the junction temperature. It is maskable by the						
1	Thermal Warning	Configuration Register (CONFIG.NO_TW).						
UOV_OC	Ī	VS Monitoring, Overcurrent Status						
0	No Fault	<u>-</u>						
1	Fault	This bit represents a logical OR combination of under–/overvoltage signals (VS) and overcurrent signals.						
1	i auit							
ULD		Underload						
0	No Underload	This bit represents a logical OR combination of all underload signals. It is maskable by the						
1	Underload	Configuration Register (CONFIG.NO_ULDx). It is also possible to deactivate this flag for HS1 or LS1, only (CONFIG.NO_ULD_HS1/LS1).						
ND511	Т	N. 5						
NRDY		Not Ready						
0	Device Ready	After transition from Standby to Active mode, an internal timer is started to allow the internal chargepump to settle before any outputs can be activated. This bit is cleared automatically after						
1	Device Not Ready	the startup is completed.						

SPI REGISTERS CONTENT

CONTROL_0 Register Address: 00h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	RW	RW	RW	RW	RW	RW	-	-	-	-	RW	RW	-	-	-	RW
Bit name	HS1	LS1	HS2	LS2	HS3	LS3	0	0	0	0	HS4	LS4	0	0	0	MODE
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	HSx	LSx		Description	Remark			
HS/LS Outputs	0	0	default	OUTx High impedance	If a driver is enabled by the control register AND the corresponding PWM enable bit is set in CONTROL_2			
OUT1-4 Driver	0	1		LSx enabled	register, the output is only activated if PWM1 (PWM2)			
Control	1	0		HSx enabled	input signal is high. Since OUT1OUT4 are half-bridge outputs, activating both HS and LS at the			
	1	1		OUTx High impedance	same time is prevented by internal logic.			

	MODE		Description	Remark
Mode Control	0	default	Standby	If MODE is set, the device is switched to Active mode. Resetting MODE forces the device to transition into Standby mode, all internal memory is cleared and all
	1		Active	output stages are switched into their default state (off). Delay of tacts should be respected before the Active mode is requested again.

CONTROL_1 Register

Address: 01h NCV7705:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	-
Bit name	HS5.1	HS5.0	HS6.1	HS6.0	HS7	HS8	HS9	LS ECFB	DAC5	DAC4	DAC3	DAC2	DAC1	DAC0	ECEN	0
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

NCV7706:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	RW	RW	RW	RW	RW	RW	RW	-	-	-	-	-	_	-	-	-
Bit name	HS5.1	HS5.0	HS6.1	HS6.0	HS7	HS8	HS9	0	0	0	0	0	0	0	0	0
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	HSx.1	HSx.0		Description	Remark
	0	0	default	OUTx High impedance	
HS Outputs OUT5,6	0	1		Output enabled, low current mode (LED mode)	If a driver is enabled by the control register AND the corresponding PWM enable bit is set in CONTROL_3 register, the output is only activated if the
Control	1	0		Output enabled, high current mode (bulb mode)	corresponding PWM input signal (PWM pin or internal PWM signal) is high.
	1	1		OUTx High impedance	

	HSx		Description	Remark
HS Outputs OUT7-9 Control	0	default	OUTx High impedance	If a driver is enabled by the control register AND the corresponding PWM enable bit is set in CONTROL_3 register, the output is only activated if the
Control	1	1 OUTx enabled		corresponding PWM input signal (PWM pin or internal PWM signal) is high.

NCV7706 ONLY:

	LS ECFB		Description	Remark
ECFB Pull-down Output	0	default	Pull-down transistor disabled (high impedance)	The ECFB-pull-down transistor can only be activated if the DAC output voltage is set to 0 V (DAC[5:0]=0). If the PWM enable bit CONTROL 2.ECFB PWM1 is
Control			Pull-down transistor enabled	set, the output will only be activated when the PWM1 signal input is high.

NCV7706 ONLY:

Electrochrom.	DAC[5:0]		Description	Remark
Mirror Reference	- 0	default	Reference voltage for ECON/ECFB differential	V(DAC) = 1 + (1.5 / 2 ⁶) · DAC[5:0] If bit CONTROL 2.FSR=0, the output voltage is
Voltage	LCON/LCI B		clamped to 1.2 V.	

NCV7706 ONLY:

	ECEN		Description	Remark
Electrochrom. Mirror Enable	0	default	Electrochromic mirror controller disabled	By enabling the electrochromic mirror controller (ECEN=1), the output driver for the external pass transistor (ECON) is enabled. In addition, OUT8 is
	1		Electrochromic mirror controller enabled	activated, regardless of the setting of CONTROL_1.HS8.

CONTROL_2 Register

Address: 02h NCV7705:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	RW	RW	RW	-	-	RW	-	RW	RW	RW	RW	-	-	RW	-	-
Bit name	OCR1	OCR2	OCR3	0	0	OCR4	0	PWMI	OUT1 PWM1	OUT2 PWM1	OUT3 PWM1	0	0	OUT4 PWM1	0	0
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

NCV7706:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	RW	RW	RW	-	ı	RW	RW	RW	RW	RW	RW	ı	-	RW	RW	RW
Bit name	OCR1	OCR2	OCR3	0	0	OCR4	OCR ECFB	PWMI	OUT1 PWM1	OUT2 PWM1	OUT3 PWM1	0	0	OUT4 PWM1	ECFB PWM1	FSR
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	OCRx		Description	Remark
Overcurrent Recovery	0	default	Overcurrent Recovery disabled	During an overcurrent event the overcurrent status bit STATUS_0/2.OCx is set and the dedicated output is switched off. (The global multi bit UOV_OC is set,
,	1		Overcurrent Recovery enabled	also). When the overcurrent recovery bit is enabled, the output will be reactivated automatically after a programmable delay time (CONTROL_3.OCRF).

	PWMI		Description	Remark
PWM Unit	0	default	Internal PWM unit disabled	The device has three different PWM sources: external pins PWM1, PWM2 and the internal PWM unit which
	1		Internal PWM unit enabled	can be used to control the lamp drivers in an additional way. PWMI selects the internal PWM unit.

	OUTx PWM		Description	Remark
PWM1/2 Selection	0	default	PWMx not selected	For the half-bridge outputs it is possible to select the PWM input pin PWM1. In this case the dedicated output (selected in CONTROL 0 register) is on if the
	1		PWMx selected	PWM input signal is high. All half-bridges are controlled by PWM1.

NCV7706 ONLY:

	FSR		Description	Remark			
DAC Full-scale Range Control	0	default	Vout = 1.5 / 2 ⁶ · DAC[5:0] clamped at 1.2 V	The default voltage at ECFB in electrochrome mode is clamped at 1.2 V, when FSR=1 the maximum value is			
	1		Vout = 1.5 / 2 ⁶ · DAC[5:0]	1.5 V.			

CONTROL_3 Register Address: 03h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW	RW
Bit name	OCR5	OCR6	OCR7	OCR8	OCR9	OUT5 PWM1	OUT6 PWM2	OUT7 PWM1	OUT8 PWM2	OUT9 PWM1	OCRF	OVUVR	IS3	IS2	IS1	IS0
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	OCRx		Description	Remark		
Overcurrent Recovery	0	default	Overcurrent Recovery disabled	During an overcurrent event the overcurrent status bit STATUS_0/2.OCx is set and the dedicated output is switched off. (The global multi bit UOV_OC is set,		
	1		Overcurrent Recovery enabled	also). When the overcurrent recovery bit is enabled, the output will be reactivated automatically after a programmable delay time (CONTROL_3.OCRF).		

	OUTx PWM		Description	Remark
PWM1/2 Selection	0	default	PWMx not selected	For the HS outputs it is possible to select the PWM input pins PWM1, PWM2 or internal PWMI unit (OUT5–8 only). In this case the dedicated output
Colconon	1		PWMx selected	(selected in CONTROL_1 register) is on if the PWM input signal is high. OUT6 and OUT8 are controlled by PWM2, OUT5,7 and OUT9 are controlled by PWM1.

	OCRF		Description	Remark	
Overcurrent Recovery Frequency	0	default	Slow Overcurrent recovery mode	If the overcurrent recovery bit is set, the output will be switched on automatically after a delay time. The	
Selection	1		Fast Overcurrent recovery mode	recovery behavior of OUT5,6 in bulb mode is not affected by this bit.	

	OVUVR		Description	Remark		
Over-/ Under-voltage	0	default	Over– and undervoltage recovery function enabled	If the OV/UV recovery is disabled by setting		
Recovery	1		No over– and undervoltage recovery	OVUVR=1, the status register STATUS_2 bits VSOV or VSUV have to be cleared after an OV/UV event.		

	IS3	IS2	IS1	IS0	Description	Remark
	0	0	0	0	OUT1	
	0 0 0 1				current sensing deactivated	
	0 0 1	0	current sensing deactivated			
	0	0	1	1	current sensing deactivated	
	0	1	0	0	current sensing deactivated	
	0	1	0	1	OUT4	
Current	0	1	1	0	OUT5	The current in all high–side power stages (except of OUT2/3) can be monitored at the
Sensing	0	1	1	1	OUT6	bidirectional multifunctional pin ISOUT/PWM2.
Selection	1	0	0	0	OUT7	This pin is a multifunctional pin and can be activated as output by setting the current
	1	0	0	1	OUT8	selection bits IS[3:0]. The selected high-side output will be multiplexed to the output ISOUT.
	1	0	1	0	OUT9	
	1	0	1	1	current sensing deactivated	
	1	1	0	0	current sensing deactivated	
	1	1	0	1	current sensing deactivated	
	1	1	1	0	current sensing deactivated	
	1	1	1	1	current sensing deactivated	

PWM_5/6 Register

Address: 08h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW															
Bit Name	FSEL5	PW5.6	PW5.5	PW5.4	PW5.3	PW5.2	PW5.1	PW5.0	FSEL6	PW6.6	PW6.5	PW6.4	PW6.3	PW6.2	PW6.1	PW6.0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	PW5[6:0]		Description	Remark
PWM Duty Cycle selector	0	default	Duty Cycle for OUT5 =	It is possible to control OUT5 by the internal PWM unit if bit PWMI is set in the control register CONTROL_2.
for OUT5	1 7Fh		(PW5[6:0] +1) / 128	If CONFIG.PWM_RESEN is set, OUT5 duty cycle is controlled by register PWM_5 with 10-bit resolution.

PWM	FSEL5		Description	Remark	
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL5 selects between 170 and 225 Hz PWM	
OUT5	1		f(PWM) = 225 Hz	frequency for OUT5.	

	PW6[6:0]		Description	Remark			
PWM Duty Cycle selector	0	default	Duty Cycle for OUT6	It is possible to control OUT6 by the internal PWM unit if bit PWMI is set in the control register CONTROL 2. If CONFIG.PWM RESEN is set,			
for OUT6	1 7Fh		= (PW6[6:0] +1) / 128	OUT6 duty cycle is controlled by register PWM_6 with 10-bit resolution.			

PWM	FSEL6		Description	Remark
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL6 selects between 170 and 225 Hz PWM
OUT6	1		f(PWM) = 225 Hz	frequency for OUT6.

PWM_7/8 Register

Address: 09h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW															
Bit Name	FSEL7	PW7.6	PW7.5	PW7.4	PW7.3	PW7.2	PW7.1	PW7.0	FSEL8	PW8.6	PW8.5	PW8.4	PW8.3	PW8.2	PW8.1	PW8.0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	PW7[6:0]		Description	Remark
PWM Duty Cycle selector	0	default	Duty Cycle for OUT7 =	It is possible to control OUT7 by the internal PWM unit if bit PWMI is set in the control register CONTROL_2.
for OUT7	1 7Fh		(PW7[6:0] +1) / 128	If CONFIG.PWM_RESEN is set, OUT7 duty cycle is controlled by register PWM_7 with 10-bit resolution.

PWM	FSEL7		Description	Remark
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL7 selects between 170 and 225 Hz PWM
OUT7	1		f(PWM) = 225 Hz	frequency for OUT7.

	PW8[6:0]		Description	Remark
PWM Duty Cycle selector for OUT8	0	default	Duty Cycle for OUT8 =	It is possible to control OUT8 by the internal PWM unit if bit PWMI is set in the control register CONTROL_2.
101 0018	1 7Fh		(PW8[6:0] +1) / 128	If CONFIG.PWM_RESEN is set, OUT8 duty cycle is controlled by register PWM_8 with 10-bit resolution.

PWM	FSEL8		Description	Remark
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL8 selects between 170 and 225 Hz PWM
OUT8	1		f(PWM) = 225 Hz	frequency for OUT8.

STATUS_0 Register Address: 10h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	R/RC	R/RC	R/RC	R/RC	R/RC	R/RC	-	-	_	-	R/RC	R/RC	-	-	-	-
Bit Name	OC HS1	OC LS1	OC HS2	OC LS2	OC HS3	OC LS3	0	0	0	0	OC HS4	OC LS4	0	0	0	0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	OCx	Description	Remark
OUT1-4 Overcurrent Detection	0	No overcurrent detected	During an overcurrent event in one of the HS or LS, the belonging overcurrent status bit STATUS_0.OCx is set and the dedicated output is switched off. (The global multi bit UOV_OC is set, also). When the overcurrent recovery bit is enabled, the output will be reactivated automatically after a programmable delay time
	1	Overcurrent detected	(CONTROL_3.OCRF). If the overcurrent recovery bit is not set the microcontroller has to clear the OC failure bit and to reactivate the output stage again.

STATUS_1 Register

Address: 11h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	R/RC	R/RC	R/RC	R/RC	R/RC	R/RC	ı	-	ı	ı	R/RC	R/RC	ı	ı	ı	_
Bit Name	ULD HS1	ULD LS1	ULD HS2	ULD LS2	ULD HS3	ULD LS3	0	0	0	0	ULD HS4	ULD LS4	0	0	0	0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	ULDx	Description	Remark
OUT1-4 Underload	0	No underload detected	For each output stage an underload status bit ULD is available. The underload detection is done in "on-mode". If the load current is below the undercurrent detection threshold for at least td_uld, the corresponding underload bit ULDx is set. If an ULD event occurs the global status bit ULD will be set.
Detection	1	Underload detected	For ULD_HS1 and ULD_LS1 it is possible to deactivate the global ULD failure bit by setting the configuration bits CONFIG.NO_ULD_HS1/LS1. With setting CONFIG.NO_ULD_OUTn the global ULD failure bit is deactivated in general.

STATUS_2 Register

Address: 12h NCV7705:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	R/RC	R/RC	-	-	R/RC	R/RC	-	-								
Bit name	OC HS5	ULD HS5	OC HS6	ULD HS6	OC HS7	ULD HS7	OC HS8	ULD HS8	OC HS9	ULD HS9	0	0	VSUV	vsov	0	0
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

NCV7706:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access type	R/RC	R/RC	R/RC	R/RC	R/RC	R/RC	R/RC	R/RC								
Bit name	OC HS5	ULD HS5	OC HS6	ULD HS6	OC HS7	ULD HS7	OC HS8	ULD HS8	OC HS9	ULD HS9	OC ECFB	ULD ECFB	VSUV	vsov	ECLO	ECHI
Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	OCx	Description	Remark
OUT5-9 Overcurrent	* * *	No overcurrent detected	During an overcurrent event in one of the HS the belonging overcurrent status bit STATUS_2.OCx is set and the dedicated output is switched off. (The global multi bit UOV_OC is set, also). When the overcurrent recovery bit is enabled, the output
Detection		will be reactivated automatically after a programmable delay time (CONTROL_3.OCRF). If the overcurrent recovery bit is not set the microcontroller has to clear the OC failure bit and to reactivate the output stage again.	

	ULDx	Description	Remark
OUT5-9 Underload	0	No underload detected	For each output stage an underload status bit ULD is available. The underload detection is done in "on-mode". If the load current is below the undercurrent detection threshold for at least td_uld, the corresponding underload bit ULDx is set.
Detection	1	Underload detected	If an ULD event occurs the global status bit ULD will be set. It is possible to deactivate the global ULD failure bit by setting the configuration bits CONFIG.NO_ULD_OUTn.

	vsuv	Description	Remark
Vs Undervoltage	0	No undervoltage detected	In case of an Vs undervoltage event, the output stages will be deactivated immediately and the corresponding failure flag will be set. By default the output stages will be reactivated
	1 Undervoltage detected	automatically after Vs is recovered unless the control bit CONTROL_3.OVUVR is set. If this is the case (OVUVR=1) the bit VSUV has to be cleared after an UV event.	

	VSOV	Description	Remark				
Vs Overvoltage	0	No overvoltage detected	In case of an Vs overvoltage event, the output stages will be deactivated immediately and the corresponding failure flag will be set. By default the output stages will be reactivated				
	1	Overvoltage detected	automatically after Vs is recovered unless the control bit CONTROL_3.0VUVR is set. If this is the case (OVUVR=1) the bit VSOV has to be cleared after an OV event.				

	ECLO	ECHI	Description	Remark					
EC Mirror	0	0	ECM output regulation in range	Two comparators monitor the voltage at pin ECFB (feedback)					
Control	0	1	ECM output V > Vregulation	in electrocrome mode. If this voltage is below / above the programmed target these bits signal the difference after at lea					
Status	1	0	ECM output V < Vregulation	32 µs. The bits are not latched and may toggle after at least 32 µs, if the ECFB voltage has not yet reached the target. They					
	1	1	not used	are not assigned to the Global Error Flag.					

PWM_5 Register

Address: 13h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW	-	-	-	-	-	RW									
Bit Name	FSEL5	0	0	0	0	0	PW5.9	PW5.8	PW5.7	PW5.6	PW5.5	PW5.4	PW5.3	PW5.2	PW5.1	PW5.0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	PW5[6:0]		Description	Remark
PWM Duty Cycle selector	0	default	Duty Cycle for OUT5 =	It is possible to control OUT5 by the internal PWM unit with 10 bit resolution if bits CONTROL_2.PWMI and
for OUT5	1 7Fh		(PW5[9:0] +1) / 1024	CONFIG.PWM_RESEN are set; PWM_5.PW5[9:0] is ignored otherwise.

PWM	FSEL5		Description	Remark			
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL5 selects between 170 and 225 Hz PWM			
OUT5	1		f(PWM) = 225 Hz	frequency for OUT5.			

PWM_6 Register Address: 14h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW	-	-	-	-	-	RW									
Bit Name	FSEL6	0	0	0	0	0	PW6.9	PW6.8	PW6.7	PW6.6	PW6.5	PW6.4	PW6.3	PW6.2	PW6.1	PW6.0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	PW6[6:0]		Description	Remark				
PWM Duty Cycle selector	0	default	Duty Cycle for OUT6 =	It is possible to control OUT6 by the internal PWM unit with 10 bit resolution if bits CONTROL_2.PWMI and				
for OUT6	1 7Fh		(PW6[9:0] +1) / 1024	CONFIG.PWM_RESEN are set; PWM_6.PW6[9:0] i ignored otherwise.				

PWM	FSEL6		Description	Remark
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL6 selects between 170 and 225 Hz PWM
OUT6	1		f(PWM) = 225 Hz	frequency for OUT6.

PWM_7 Register

Address: 15h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW	-	-	-	-	-	RW									
Bit Name	FSEL7	0	0	0	0	0	PW7.9	PW7.8	PW7.7	PW7.6	PW7.5	PW7.4	PW7.3	PW7.2	PW7.1	PW7.0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	PW7[6:0]		Description	Remark
PWM Duty Cycle selector	0	default	Duty Cycle for OUT7 =	It is possible to control OUT7 by the internal PWM unit with 10 bit resolution if bits CONTROL_2.PWMI and
for OUT7	1 7Fh		(PW7[9:0] +1) / 1024	CONFIG.PWM_RESEN are set; PWM_7.PW7[9:0] is ignored otherwise.

PWM	FSEL7		Description	Remark
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL7 selects between 170 and 225 Hz PWM
OUT7	1		f(PWM) = 225 Hz	frequency for OUT7.

PWM_8 Register Address: 16h

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	RW	-	-	_	-	-	RW									
Bit Name	FSEL8	0	0	0	0	0	PW8.9	PW8.8	PW8.7	PW8.6	PW8.5	PW8.4	PW8.3	PW8.2	PW8.1	PW8.0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	PW8[9:0]		Description	Remark
PWM Duty Cycle selector	0	default	Duty Cycle for OUT8 =	It is possible to control OUT8 by the internal PWM unit with 10 bit resolution if bits CONTROL_2.PWMI and
for OUT8	1 7Fh		(PW8[9:0] +1) / 1024	CONFIG.PWM_RESEN are set; PWM_8.PW8[9:0] is ignored otherwise.

PWM	FSEL8		Description	Remark
Frequency selector for	0	default	f(PWM) = 170 Hz	Bit FSEL8 selects between 170 and 225 Hz PWM
OUT8	1		f(PWM) = 225 Hz	frequency for OUT8.

CONFIG Register Address: 3Fh

NCV7705:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	-	RW	-	-	-	-	-	-	-	-	RW	RW	RW	-	RW	-
Bit Name	0	PWM RESEN	0	0	0	0	0	0	0	0	NO_ULD HS1	NO_ULD LS1	NO_ TW	0	NO_ULD OUTn	0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

NCV7706:

Bit	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Access Type	ı	RW	-	-	-	ı	-	ı	RW	ı	RW	RW	RW	ı	RW	_
Bit Name	0	PWM RESEN	0	0	0	0	0	0	ECM LSPWM	0	NO_ULD HS1	NO_ULD LS1	NO_ TW	0	NO_ULD OUTn	0
Reset Value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

	NO_ULD HS1	NO_ULD LS1		Description	Remark
	0	0	default	Global underload flag at HS1/LS1 active	
Global Underload Flag HS1/LS1	0	1		For ULD_HS1 and ULD_LS1 it is possible to deactivate the global ULD failure bit by setting the configuration bits	
	1	0		No global underload flag at HS1	CONFIG.NO_ULD_HS1/LS1.With setting CONFIG.NO_ULD_OUTn the global ULD failure bit is deactivated in general.
	1	1		No global underload flag at HS1/LS1	on to dedouvated in goneral.

	NO_TW		Description	Remark
No Thermal Warning Flag	0	default	Thermal warning flag active	The global thermal warning bit TW can be
33	1		No thermal warning flag active	deactivated.

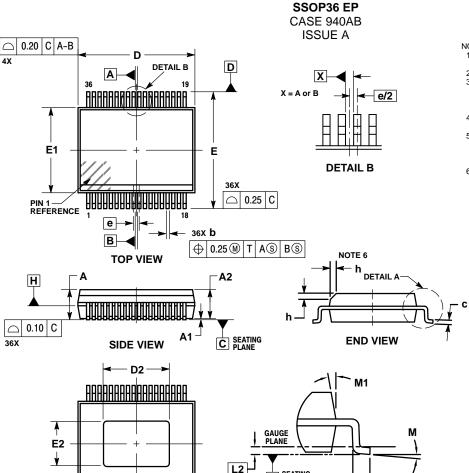
	NO_ULD_OUTn		Description	Remark
Global Undeload Flag	0	default	Global underload flag active	By setting CONFIG.NO_ULD_OUTn the global
OUTn	1		No global underload flag active	ULD failure bit is deactivated in general.

NCV7706 ONLY:

	ECM_LSPWM		Description	Remark
ECM PWM Discharge	0	default	LS PWM feature disabled	If this bit is set, automatic PWM discharge on the ECM output is enabled. In case of PWM
g.	1		LS PWM feature enabled	discharge the Overcurrent recovery feature is disabled, regardless of the setting of CONTROL_2.OC_ECFB.

	PWM_RESEN		Description	Remark
Increased PWM	0	default	7 bits PWM	By default, 7 bits internal PWM resolution is used and duty cycle is controlled by registers PWM_5/6 and PWM_7/8.
Resolution	1		10 bits PWM	If this bit is set, 10 bits internal PWM resolution is used and duty cycle is controlled by registers PWM_5, PWM_6, PWM_7 and PWM_8.

PACKAGE DIMENSIONS



BOTTOM VIEW

NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: MILLIMETERS.

 3. DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION. SHALL BE 0.13 TOTAL IN EXCESS OF THE & DIMENSION AT MMC.

 4. DIMENSION & SHALL BE MEASURED BETWEEN 0.10 AND 0.25 FROM THE TIP.

 5. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. DIMENSIONS D AND E1 SHALL BE DETERMINED AT DATUM H.

 6. THIS CHAMFER FEATURE IS OPTIONAL. IF IT IS NOT PRESENT, A PIN ONE IDENTIFIER MUST BE LOACATED WITHIN THE INDICATED AREA.

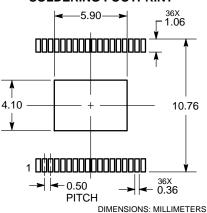
	MILLIMETERS	
DIM	MIN	MAX
Α		2.65
A1		0.10
A2	2.15	2.60
b	0.18	0.30
C	0.23	0.32
D	10.30 BSC	
D2	5.70	5.90
Е	10.30 BSC	
E1	7.50 BSC	
E2	3.90	4.10
e	0.50 BSC	
h	0.25	0.75
L-	0.50	0.90
2	0.25 BSC	
M	0°	8°
M1	5°	15°

SOLDERING FOOTPRINT

DETAIL A

36X L

C SEATING PLANE



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